

Energy Dispersive X-Ray Fluorescence (ED-XRF) spectrometer

Model No. : EX 3600 M, Jordan Valley, Israel

Principle: Characteristic x-rays, which are produced due to the de-excitation of atoms, provide un-ambiguous signature of the elements present in the sample.

Excitation Source:

Low power (50 watt) Rh X-ray tube / Ge secondary target with provision for seven secondary filters to reduce the continuum background.

Detector: LEO Si(Li) detector having $R=140 \pm 10$ eV at 5.9 keV of Mn K X-rays

Elements Range: Al to U, For Low Z elements He purging and Vacuum facility

Concentration range: ppm to % level

Samples form which can be analysed: Solids, Liquids, Powders

Nature of samples: Metallurgical, Biological, Geological, Forensic etc.

Type of Analysis at ACD, BARC:

Quantitative, Qualitative, Rapid survey analysis for identification purposes

Determination of Cr, Cu, Zr, Nb, Al in alloy samples

Determination of As, Hg etc. in ion exchange membranes, which are used for either preconcentration or separation

Analysis of brass, steel, incoloy samples for the determination of elemental composition

